Form PTO 1449		U.S. DEPARTMEN PATENT AND TR	T OF COMMERCE	ATTY DOCKET NO. 248772US2CRL		SERIAL NO. 10/777,185						
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M	AA	6,993,358, B2	01/31/06	Shlotsu et al.							
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	AQ	2002-542639	12/10/02	Japan (w/computer generated partial English translation corresponding to WO 00/49824)		×					
	AR	WO 02/13457 A2	02/14/02	WIPO			'				
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